

MICRON.100C1

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

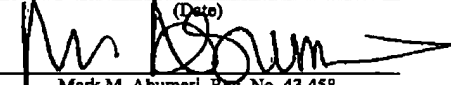
Appl. No. : 10/608,913
Applicant : Craig A. Hickman
Filed : June 26, 2003
For : DEVICE AND METHOD OF
CORRECTING EXPOSURE
DEFECTS IN
PHOTOLITHOGRAPHY
Group Art Unit : 2851
Examiner : Rodney Evan Fuller
Attny Docket No. : MICRON.100C1
Customer No. : 20,995

Confirmation No. 7050

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(Date)
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AMENDMENT AND RESPONSE TO FINAL OFFICE ACTION

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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Dear Sir:

In response to the final Office Action of June 10, 2004, the Applicant submits the following amendment and remarks for consideration in connection with the above-captioned application.

Amendments to the Claims are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks/Arguments begin on page 7 of this paper.

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FIRM: U.S. Patent and Trademark Office

FACSIMILE NO.: 703-872-9306

FROM: Mark M. Abumeri

CLIENT CODE: MICRON.100C1

APPLICATION NO.: 10/608/913

ENCLOSURE: Amendment and Response to Final Office Action in eight (8) pages

PAGES: 10 (INCLUDING THIS SHEET)

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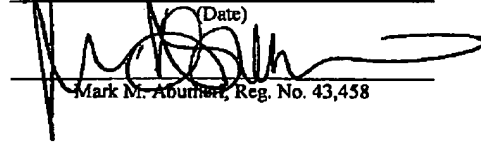
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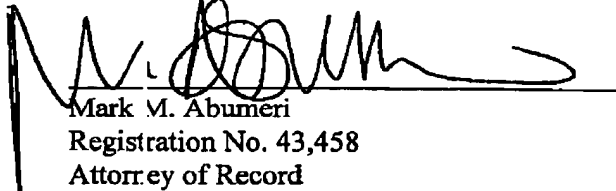
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